Power LDMOS transistor

Rev. 3 — 16 November 2010

Product data sheet

1. Product profile

1.1 General description

40 W LDMOS power transistor for base station applications at frequencies from 700 MHz to 1 GHz.

Table 1. Typical performance

Typical RF performance at $T_{case} = 25 \ ^{\circ}C$ in a class-AB production test circuit.

Mode of operation	f	V_{DS}	P _{L(AV)}	Gp	ησ	ACPR
	(MHz)	(V)	(W)	(dB)	(%)	(dBc)
2-carrier W-CDMA ^[1]	791 to 821	28	2.5	23.0	15.0	-42.5

[1] Test signal: 3GPP test model 1; 64 DPCH; PAR = 7.5 dB at 0.01 % probability on CCDF per carrier; carrier spacing 5 MHz.

1.2 Features and benefits

- Typical 2-carrier W-CDMA performance at frequencies of 791 MHz and 821 MHz, a supply voltage of 28 V and an I_{Dq} of 390 mA:
 - Average output power = 2.5 W
 - Power gain = 23.0 dB
 - Efficiency = 15.0 %
 - ◆ ACPR = -42.5 dBc
- Easy power control
- Integrated ESD protection
- Enhanced ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (728 MHz to 960 MHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)
- Integrated current sense

1.3 Applications

 RF power amplifiers for W-CDMA base stations and multi carrier GSM and LTE applications in the 728 MHz to 960 MHz frequency range



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2. Pinning information

Table 2.	Pinning	
Pin	Description	Simplified outline Graphic symbol
1	drain	
2	gate	
3	source	
4, 5	sense drain	
6, 7	sense gate	6 7 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3 3

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information				
Type number Package				
	Name	Description	Version	
BLF6G10L-40BRN	-	flanged ceramic package; 2 mounting holes; 6 leads	SOT1112A	

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage		-	65	V
V _{GS}	gate-source voltage		-0.5	+11	V
V _{GS(sense)}	sense gate-source voltage	9	-0.5	+9	V
I _D	drain current		-	11	А
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

5. Thermal characteristics

Table 5.	Thermal characteristics			
Symbo	Parameter	Conditions	Тур	Unit
R _{th(j-case}) thermal resistance from junction to case	T_{case} = 80 °C; P_L = 2.5 W(CW)	1.7	K/W

6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 0.5 mA	65	-	-	V
V _{GS(th)}	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; \text{ I}_{D} = 59 \text{ mA}$	1.4	1.9	2.4	V
I _{Dq}	quiescent drain current	sense transistor: $I_{DS} = 8.2 \text{ mA};$ $V_{DS} = 26.5 \text{ V}$ main transistor: $V_{DS} = 28 \text{ V}$	340	390	440	mA
I _{DSS}	drain leakage current	V_{GS} = 0 V; V_{DS} = 28 V	-	-	1.4	μΑ
I _{DSX}	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{GS} = V_{GS(th)} + 3.75 \; V; \\ V_{DS} = 10 \; V \end{array}$	8.8	10	-	A
I _{GSS}	gate leakage current	V_{GS} = 11 V; V_{DS} = 0 V	-	-	140	nA
g fs	forward transconductance	V_{DS} = 10 V; I _D = 2.9 A	2.7	4.3	-	S
R _{DS(on)}	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 V;$ $I_D = 2.063 A$	0.09	0.25	0.39	Ω

7. Application information

Table 7. Application information

Mode of operation: 2-carrier W-CDMA; PAR = 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 DPCH; f_1 = 788.5 MHz; f_2 = 793.5 MHz; f_3 = 818.5 MHz; f_4 = 823.5 MHz; RF performance at V_{DS} = 28 V; $I_{Dq(nom)}$ = 390 mA; T_{case} = 25 °C; unless otherwise specified in a class AB production test circuit.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
P _{L(AV)}	average output power		-	2.5	-	W
Gp	power gain	$P_{L(AV)} = 2.5 \text{ W}$	22	23.0	-	dB
RL _{in}	input return loss	$P_{L(AV)} = 2.5 \text{ W}$	-	-15	-10	dB
η_D	drain efficiency	$P_{L(AV)} = 2.5 \text{ W}$	13	15	-	%
ACPR	adjacent channel power ratio	$P_{L(AV)} = 2.5 \text{ W}$	-	-42.5	-38	dBc

Table 8.Application information

Mode of operation; 1-carrier W-CDMA; PAR = 7.5 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 DPCH; f = 821 MHz; RF performance at $V_{DS} = 28$ V; $I_{Dq(nom)} = 390$ mA; $T_{case} = 25$ °C; unless otherwise specified in a class AB production test circuit.

- case -	,					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
PAR	peak-to-average ratio	$P_{L(AV)} = 10 \text{ W at } 0.01 \text{ \%}$ probability on CCDF	5.5	5.9	-	dB

7.1 Ruggedness in class-AB operation

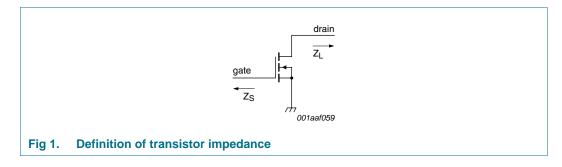
The BLF6G10L-40BRN is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: V_{DS} = 28 V; I_{Dq} = 390 mA; P_L = 32 W; f = 791 MHz and 821 MHz.

7.2 Impedance information

Table 9.	Typical impedance per section
$l_{\rm p} = 300$	mΔ· main transistor V _{PO} – 28 V

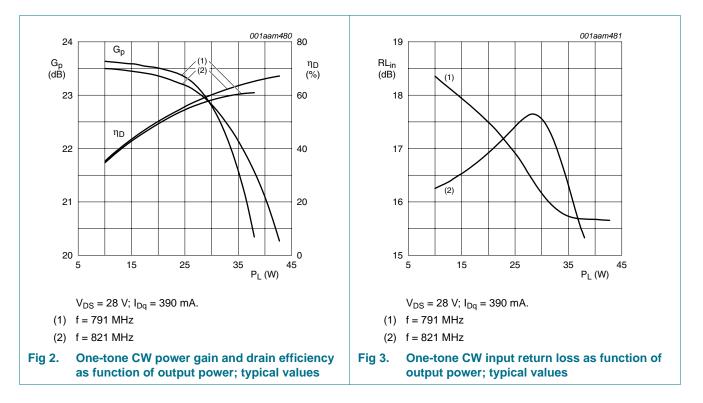
$I_{Dq} = 390 \text{ mA}, \text{ main transistor}$	$v_{DS} = 20 v$	
f	Z _S [1]	Z _L [1]
(MHz)	(Ω)	(Ω)
800	2.0 - j5.0	5.3 + j2.9
810	2.0 – j5.5	5.6 + j2.3

[1] Z_S and Z_L defined in Figure 1.

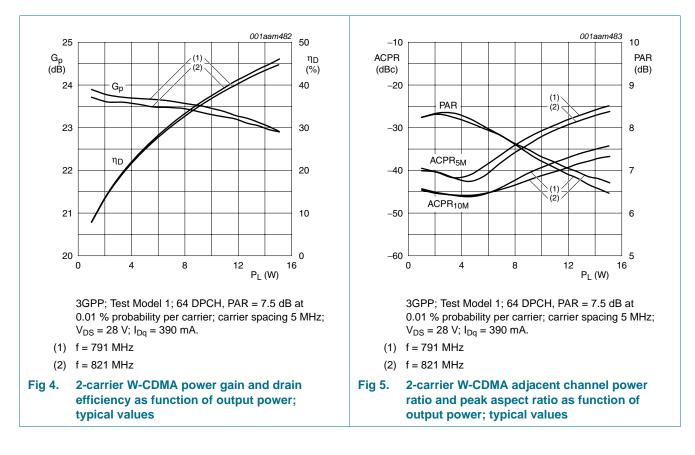


7.3 Graphs

7.3.1 1 Tone CW



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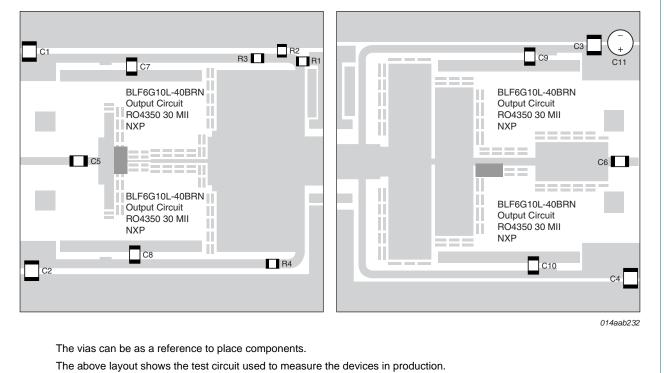
7.3.2 2-carrier W-CDMA (5 MHz spacing)

BLF6G10L-40BRN

Power LDMOS transistor

8. Test information

8.1 Test circuit



See Table 10 for list of components.

Fig 6. Component layout

Table 10. List of components See Figure 6 for component layout

See <u>Figure o</u> for c	отронентауош.		
Component	Description	Value	Remarks
C1, C2, C3, C4	multilayer ceramic chip capacitor	10 μF	[1]
C5,C6	multilayer ceramic chip capacitor	47 pF	[2]
C7, C8	multilayer ceramic chip capacitor	100 pF	[2]
C9, C10	multilayer ceramic chip capacitor	30 pF	[2]
C11	electrolytic capacitor	470 μF; 63 V	,
R1	chip resistor	820 Ω	^[3] 1206
R2	chip resistor	2.2 kΩ	^[3] 1206
R3, R4	chip resistor	15 Ω	[3] 1206

[1] Murata or capacitor of same quality.

[2] American Technical Ceramics type 100B or capacitor of same quality.

[3] Philips or resistor of same quality.

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9. Package outline

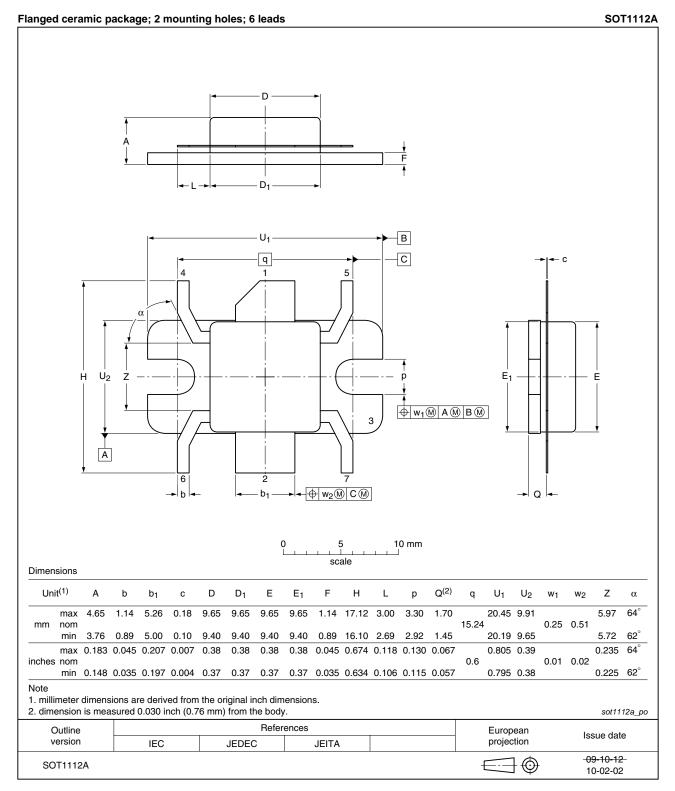


Fig 7. Package outline SOT1112A

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10. Abbreviations

Table 11.	Abbreviations
Acronym	Description
3GPP	3rd Generation Partnership Project
CCDF	Complementary Cumulative Distribution Function
DPCH	Dedicated Physical CHannel
ESD	ElectroStatic Discharge
GSM	Global System for Mobile communications
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LTE	Long Term Evolution
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
VSWR	Voltage Standing-Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 12.Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BLF6G10L-40BRN v.3	20101116	Product data sheet	-	BLF6G10L-40BRN v.2	
Modifications:	 In the entire data sheet the typical value of I_{Dq} has been changed to 390 mA. 				
	 <u>Table 6 on page 3</u>: the values of I_{Dq} have been changed. 				
	 <u>Table 7 on page 3</u>: Some values have been changed. 				
	 <u>Section 7.1 on page 3</u>: The value of VSWR has been corrected. 				
BLF6G10L-40BRN v.2	20100827	Preliminary data sheet	-	BLF6G10L-40BRN v.1	
BLF6G10L-40BRN v.1	20100809	Preliminary data sheet	-	-	

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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